PRELIMINARY AMENDMENT U.S. Application No.:

AMENDMENTS TO THE CLAIMS

This listing of claims will replace all prior versions and listings of claims in the application:

LISTING OF CLAIMS:

Claims 1-17 (canceled).

18. (new): A high-strength, low-temperature-sintered ceramic composition having a structure comprising hexagonal SrAl₂Si₂O₈ and an Al₂O₃ crystal, said ceramic composition having a bending strength of 300 MPa or more.

19. (new): A high-strength, low-temperature-sintered ceramic composition comprising hexagonal SrAl₂Si₂O₈ in an Al₂O₃-SiO₂-SrO-based matrix, which contains Al₂O₃ crystal grains and has a bending strength of 300 MPa or more.

20. (new): The high-strength, low-temperature-sintered ceramic composition according to claim 19, wherein said matrix is an amorphous phase, in which hexagonal SrAl₂Si₂O₈ is precipitated.

21. (new): The high-strength, low-temperature-sintered ceramic composition according to claim 19, wherein said matrix is substantially composed of a SrAl₂Si₂O₈ crystal, at least part of which is hexagonal SrAl₂Si₂O₈.

22. (new): The high-strength, low-temperature-sintered ceramic composition according to claim 19, wherein said matrix contains monoclinic SrAl₂Si₂O₈.

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- 23. (new): A high-strength, low-temperature-sintered ceramic composition having a structure comprising a SrAl₂Si₂O₈ crystal and an Al₂O₃ crystal, said SrAl₂Si₂O₈ crystal being composed of hexagonal SrAl₂Si₂O₈ alone or hexagonal SrAl₂Si₂O₈ and monoclinic SrAl₂Si₂O₈, a peak intensity ratio represented by I₁₀₁ / (I₁₀₁ + I₀₀₂) x 100 being 5% or more in an X-ray diffraction measurement by a Cu-Kα line, wherein I₁₀₁ represents a peak intensity of a (101) plane of the hexagonal SrAl₂Si₂O₈, and I₀₀₂ represents a peak intensity of a (002) plane of the monoclinic SrAl₂Si₂O₈, and said ceramic composition having a bending strength of 300 MPa or more.
- 24. (new): The high-strength, low-temperature-sintered ceramic composition according to claim 23, wherein said peak intensity ratio is 50% or more.
- 25. (new): The high-strength, low-temperature-sintered ceramic composition according to claim 23, which has a structure comprising a matrix substantially composed of the SrAl₂Si₂O₈ crystal, which contains Al₂O₃ crystal grains, said SrAl₂Si₂O₈ crystal being composed of hexagonal SrAl₂Si₂O₈ alone or hexagonal SrAl₂Si₂O₈ and monoclinic SrAl₂Si₂O₈, and a percentage of said hexagonal SrAl₂Si₂O₈ in said SrAl₂Si₂O₈ crystal being 60% or more, and said ceramic composition having a bending strength of 400 MPa or more.
- 26. (new): The high-strength, low-temperature-sintered ceramic composition according to claim 18, wherein said A1₂O₃ crystal grams leave an average diameter of 1 μm or less.
- 27. (new): The high-strength, low-temperature-sintered ceramic composition according to claim 18, wherein it comprises (a) 100% by mass of main components comprising 10-60% by

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mass of Al (as Al₂O₃), 25-60% by mass of Si (as SiO₂) and 7.5-50% by mass of Sr (as SrO), (b) auxiliary components comprising at least one selected from the group consisting of 0.1-10% by mass of Bi (as Bi₂O₃), 0.1-5% by mass of Na (as Na₂O), 0.1-5% by mass, of K (as K₂O) and 0.1-5% by mass of Co (as CoO), and at least one selected from the group consisting of 0.01-5% by mass of Cu (as CuO), 0.01-5% by mass of Mn (as MnO₂), 0.01-5% by mass of Ag and 0.01-2% by mass of Zr (as ZrO₂), and (c) inevitable impurities.

- 28. (new): The high-strength, low-temperature-sintered ceramic composition according to claim 18, wherein it comprises (a) 100% by mass of main components comprising 10-60% by mass of Al (as Al₂O₃), 25-60% by mass of Si (as SiO₂), 7.5-50% by mass of Sr (as SrO) and 20% or less by mass of Ti (as TiO₂), (b) auxiliary components comprising at least one selected from the group consisting of 0.1-10% by mass of Bi (as Bi₂O₃), 0.1-5% by mass of Na (as Na₂O), 0.1-5% by mass of K (as K₂O) and 0.1-5% by mass of Co (as CoO), and at least one selected from the group consisting of 0.01-5% by mass of Cu (as CuO), 0.01-5% by mass of Mn (as MnO₂), 0.01-5% by mass of Ag and 0.01-2% by mass of Zr (as ZrO₂), and (c) inevitable impurities.
- 29. (new): The high-strength, low-temperature-sintered ceramic composition according to claim 18, wherein it comprises 10-60% by mass of Al (as Al₂O₃), 25-60% by mass of Si (as SiO₂), 7.5-50% by mass of Sr (as SrO), and inevitable impurities.
- 30. (new): A method for producing the high-strength, low-temperature-sintered ceramic composition recited in claim 18, by sintering a ceramic green body comprising aluminum oxide,

silicon oxide and strontium oxide, or aluminum oxide, silicon oxide, strontium oxide and titanium oxide as main starting materials, under such temperature and time conditions that a ratio of hexagonal SrAl₂Si₂O₈ in a SrAl₂Si₂O₈ crystal formed in a ceramic structure becomes 5% or more.

- 31. (new): A laminated electronic part comprising pluralities of dielectric layers made of the high-strength, low-temperature-sintered ceramic composition recited in claim 18, each of said dielectric layers being provided with a conductive pattern of a low-melting-point metal.
- 32. (new): The laminated electronic part according to claim 31, wherein said low-melting-point metal is silver, copper, gold or an alloy thereof.
- 33. (new): The laminated electronic part according to claim 31, wherein said conductive pattern constitutes an inductance element and/or a capacitance element.
- 34. (new): The laminated electronic part according to claim 31, onto which at least one selected from the group consisting of an inductance element, a capacitance element, a switching element and a filter element is mounted.